



ELECTRONICS

Material properties of Rubalit[®],
Alunit[®] and Zirkolit[®]

Advanced Ceramics for Electronic Applications

CeramTec
THE CERAMIC EXPERTS

Industrial Solutions
CeramTec-Platz 1-9
73207 Plochingen, Germany

Telefon +49 (0) 7153.611-11900
Email myceramtec@ceramtec.de
Web www.ceramtec-group.com



CA230126/EN/100/2304/IM

Material Properties of Rubalit®, Alunit® and Zirkolit®

Property	Definition Property	Unit	Range	Rubalit® 708 D**	Rubalit® 708S C***	Rubalit® 708 HP C***	Rubalit® 710F C***	Rubalit® ZTA	Thomit® 600 D**	Alunit® AIN 170 C***	Alunit® AIN 170 D**	Zirkolit® ZrO2 5Y C***
Al2O3 content		[wt-%]	≥	95.8	96.0	96.0	+/- 99.6	90 +/- 1,2	45.0			
Surface roughness R _a	@ as fired surface	[µm]	≤	0.8	0.6	0.6	0.12	≤ 0,4	0.9	0.6	1.0	0.2
Density		[g/cm³]	≥	3.73	3.73	3.73	3.80	≥ 3,95		3.26	3.28	5.7
Bending strength DR sigma 0	double ring method @ 0.32 mm; thickness @ rings 6 / 12 mm double ring method @ 0.50 mm; thickness @ rings 6 / 12 mm double ring method @ 0.63 mm; thickness @ rings 6 / 12 mm double ring method @ 1.00 mm; thickness @ rings 6 / 12 mm double ring method @ 1.00 mm; thickness @ rings 7 / 14 mm double ring method @ 1.50 mm; thickness @ rings 6 / 12 mm	[MPa] [MPa] [MPa] [MPa] [MPa]	≥ ≥ ≥ ≥ ≥	300 300	450	450	420 420	≥ 625	130	320 320	200	800
Coefficient of thermal expansion (CTE)	@ 100°C – 200°C	@ 20°C – 300°C****	[10-6/K]	+/-	6.0 – 8.0	6.0 – 8.0	6.0 – 8.0	7,1****	5.0 – 7.0	3.7 – 5.7	3.5 – 5.5	9 – 12
	@ 100°C – 300°C	@ 20°C – 600°C****	[10-6/K]	+/-	6.0 – 8.0	6.0 – 8.0	6.0 – 8.0	8****	5.0 – 7.0	3.7 – 5.7	4.0 – 6.0	9 – 12
	@ 100°C – 600°C	@ 20°C – 900°C****	[10-6/K]	+/-	6.7 – 8.7	6.7 – 8.7	6.7 – 8.7	8,6****	5.5 – 7.5	4.5 – 5.9	4.5 – 6.5	9 – 12
	@ 100°C – 800°C		[10-6/K]	+/-	7.0 – 9.0	7.0 – 9.0	7.0 – 9.0		5.5 – 7.5	4.8 – 6.2	4.6 – 6.7	9 – 12
Dielectric constant	@ 1 GHz @ 2mm thickness @ Ra ≤ 0,4 µm	-/-	+/-	8.3 – 11.3	8.3 – 11.3	8.3 – 11.3	8.5 – 11.5	10,5		7.2 – 9.8		
	@ 10 MHz @ 2mm thickness @ Ra ≤ 0,4 µm	-/-	+/-	8.3 – 11.3	8.3 – 11.3	8.3 – 11.3	8.5 – 11.5			7.2 – 9.8		
	@ 100 MHz @ 2mm thickness @ Ra ≤ 0,4 µm	-/-	+/-	8.3 – 11.3	8.3 – 11.3	8.3 – 11.3	8.5 – 11.5			7.2 – 9.8		
Dielectric loss factor	@ 1 GHz @ 2mm thickness @ Ra ≤ 0,4 µm	[10-3]	≤	10	10			≤ 5		10		
	@ 10 MHz @ 2mm thickness @ Ra ≤ 0,4 µm	[10-3]	≤	10	10					10		
	@ 100 MHz @ 2mm thickness @ Ra ≤ 0,4 µm	[10-3]	≤	10	10					10		
Dielectric strength	@ 0.500 mm thickness	[kV/mm]	≥					≥ 25		15		
	@ 0.635 mm thickness	[kV/mm]	≥		15	15	15		15			10
	@ 1.000 mm thickness	[kV/mm]	≥						15			
Specific heat capacity	@ 100°C	[J/g K]	≥	0.9	0.7	0.8	0.8			0.7	0.7	0.4
	@ 20°C	[J/g K]	≥	0.7	0.7	0.7	0.7	0,7		0.6	0.6	0.3
Thermal conductivity*	@ 20°C @ Xe-flash @ sample 16*16 mm² @ material specific thickness ≤ 3,5 mm	[W/mK]		22.0	22.0	22.0	25.0	26	2.0	170	170	1.5
Volume resistivity	@ 20°C	[Ohm cm]	≥	10 ¹³	10 ¹³	10 ¹³	10 ¹³	≥ 1014		10 ¹⁴	10 ¹⁴	
	@ 200°C	[Ohm cm]	≥	10 ¹¹	10 ¹¹	10 ¹¹	10 ¹¹			10 ¹³	10 ¹³	
	@ 400°C	[Ohm cm]	≥	10 ⁹	10 ⁹	10 ⁹	10 ⁹			10 ¹²	10 ¹²	
	@ 600°C	[Ohm cm]	≥	10 ⁷	10 ⁷	10 ⁷	10 ⁷			10 ⁹	10 ⁹	
	@ 800°C	[Ohm cm]	≥		10 ⁷	10 ⁷	10 ⁷			10 ⁹		
Chemical composition		-/-		The material main component is Al ₂ O ₃ . Residue mainly consists of MgO, SiO ₂ and CaO and traces of other elements.	The material main component is Al ₂ O ₃ . Residue mainly consists of MgO, SiO ₂ and CaO and traces of other elements.	The material main component is Al ₂ O ₃ . Residue mainly consists of MgO, SiO ₂ and CaO and traces of other elements.	The material main component is Al ₂ O ₃ . Residue mainly consists of MgO and traces of other elements.	The material main components are Al ₂ O ₃ and ZrO ₂ . Additional component is Y ₂ O ₃ . Residue mainly consists of MgO, SiO ₂ and CaO and traces of other elements.				The material main component is ZrO ₂ . Additional components are Y ₂ O ₃ and traces of other elements.

* typical value based on a measurement precision of +/- 10%

** Dry pressed

*** Tape casted

**** for Rubalit ZTA

Indexes and parameters for ceramic substances

In order to profile ceramic substances certain parameters are indicated. The crystalline nature of these substances, statistical fluctuations in the composition of the substances and in the factors that impact on the production processes indicate that the figures quoted are typically mean values and hence the substance parameters quoted in this brochure are only standard, recommended or guide values that might differ given dissimilar dimensions and production processes.